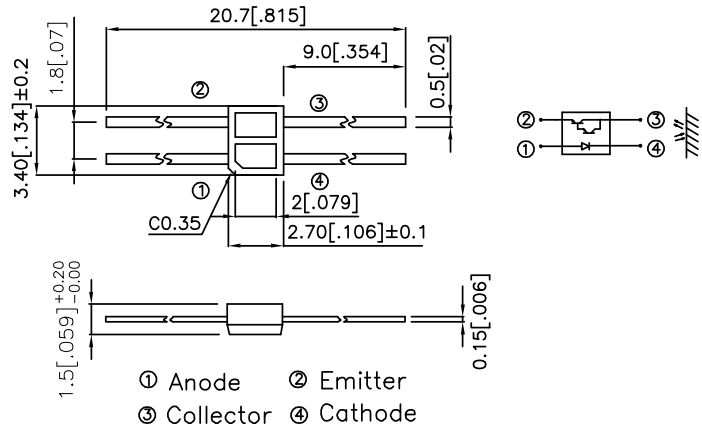


## SUBMINIATURE, HIGH SENSITIVITY PHOTOINTERRUPTER

### Features

- Compact and thin
- Visible light cut-off type
- High sensitivity
- RoHS Compliant.



### Applications

- Cassette tape recorders, VCRs.
- Floppy disk drives.
- Various microcomputerized control equipment.

UNIT : MM[INCH]

TOLERANCE : ±0.25[±0.01] UNLESS OTHERWISE NOTED.

### \*Absolute Maximum Ratings (TA=25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	I <sub>F</sub>	50	mA
	Reverse voltage	V <sub>R</sub>	6	V
	Power dissipation	P	75	mW
Output	Collector power dissipation	P <sub>C</sub>	75	mW
	Collector current	I <sub>C</sub>	50	mA
	Collector-emitter voltage	V <sub>CEO</sub>	35	V
	Emitter-collector voltage	V <sub>ECO</sub>	6	V
Operating temperature		T <sub>opr</sub>	-25~+85	°C
Storage temperature		T <sub>stg</sub>	-40~+100	°C
Soldering temperature (1/16 inch from body for 5 seconds)		T <sub>sol</sub>	260	°C



## Electrical / Optical Characteristics at $T_A=25^\circ\text{C}$

Parameter		Symbol	Conditions	Min.	Typ.	Max.	Unit	
Input	Forward voltage	$V_F$	$I_F=20\text{mA}$	1.0	1.2	1.5	V	
	Reverse current	$I_R$	$V_R=6\text{V}$	—	—	10	$\mu\text{A}$	
Output	Collector dark current	$I_{CEO}$	$V_{CE}=10\text{V}, I_F=0\text{mA}$	—	—	$10^{-6}$	A	
Transfer Characteristics	*1 Collector Current		$I_C$	$V_{CE}=2\text{V}, I_F=4\text{mA}$	—	3	—	mA
	*2 Leak Current		$I_{LEAK}$	$V_{CE}=5\text{V}, I_F=4\text{mA}$	—	—	5	$\mu\text{A}$
	Response time	Rise time	$t_r$	$V_{CE}=2\text{V}, I_C=10\text{mA}$ $R_L=1\text{K}\Omega, d=1\text{mm}$	—	80	400	$\mu\text{Sec}$
		Fall time	$t_f$		—	70	400	$\mu\text{Sec}$

\*1 The condition and arrangement of the reflective object are shown below.

\*2 Without reflective object.

Test Condition and Arrangement for Collector Current

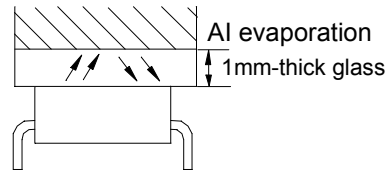


Fig. 1 Forward Current vs. Forward Voltage

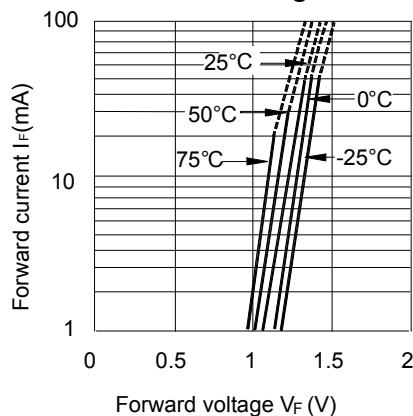


Fig. 2 Collector Current vs. Forward Current

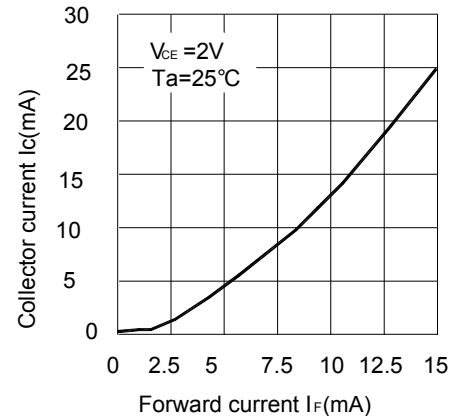


Fig. 3 Collector Current vs. Collector-emitter Voltage

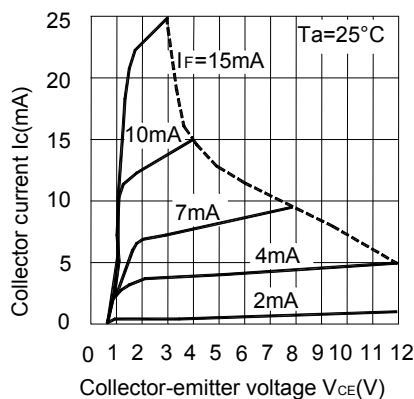


Fig. 4 Relative Collector Current vs. Ambient Temperature

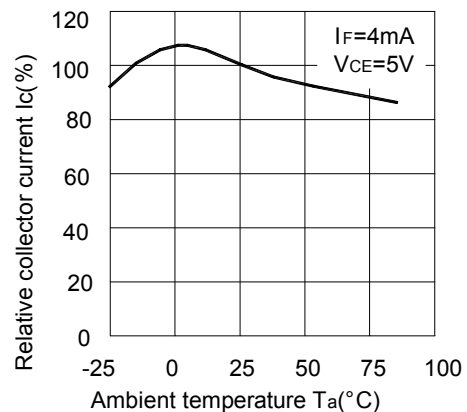
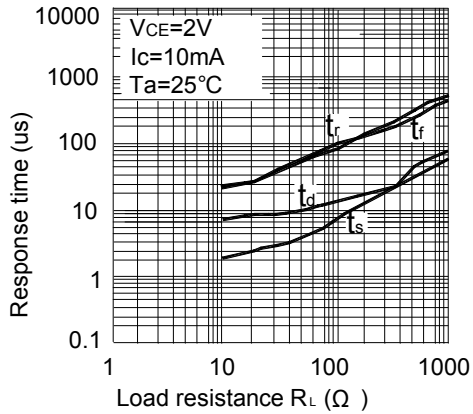


Fig. 5 Response Time vs. Load Resistance



Test Circuit for Response Time

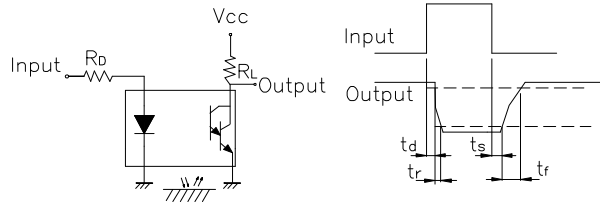


Fig. 6 Collector Dark Current vs. Ambient Temperature

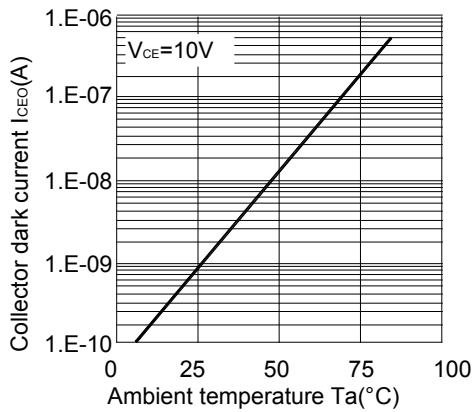


Fig. 7 Relative Collector Current vs. Distance between Sensor and Al Evaporation Glass

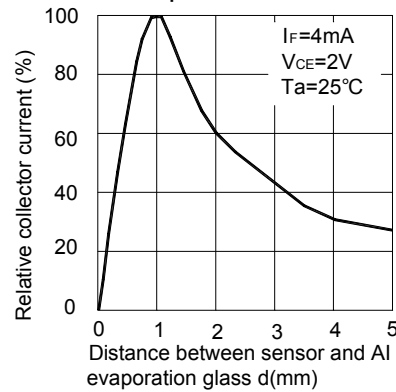


Fig. 8 Relative Collector Current vs. Card Moving Distance (1)

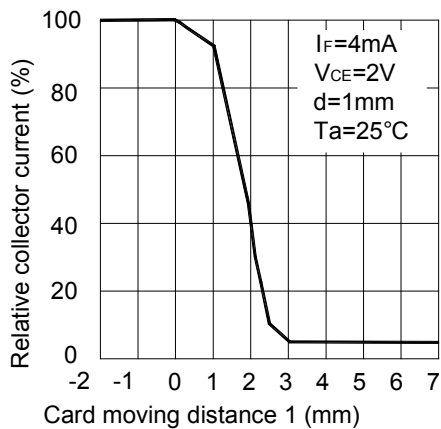
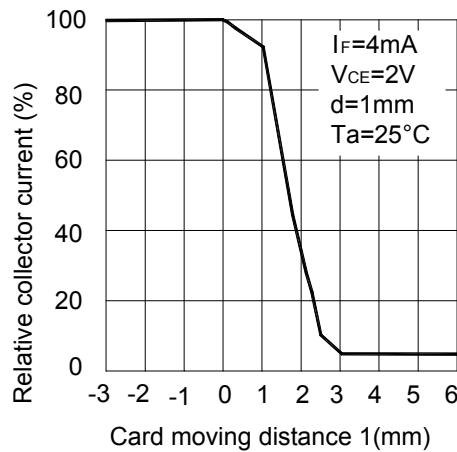
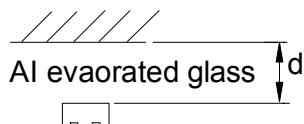


Fig. 9 Relative Collector Current vs. Card Moving Distance (2)



## Test Condition for Distance & Detecting Position Characteristics

Correpond to Fig. 7



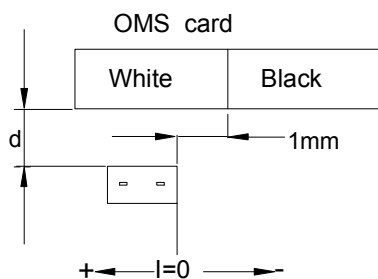
Correpond to Fig. 8

Test condition

$$I_F = 4\text{mA}$$

$$V_{CE} = 2\text{V}$$

$$d = 1\text{mm}$$



Correpond to Fig. 9

Test condition

$$I_F = 4\text{mA}$$

$$V_{CE} = 2\text{V}$$

$$d = 1\text{mm}$$

